

Search Notes

Application No.

10/622,466

Examiner

Stephen W. Smoot

Applicant(s)

NA ET AL.

Art Unit

2813

SEARCHED

Class	Subclass	Date	Examiner
438	458	7/24/2004	SWS
438	459	7/24/2004	SWS
438	463	7/24/2004	SWS
438	479	7/24/2004	SWS
438	940	7/24/2004	SWS
438	977	7/24/2004	SWS
Updated	Above	1/19/2005	SWS

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
Same as Above		1/19/2005	SWS

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Key Words: Gallium Nitride - GaN; Growth Substrate - Sapphire, Silicon Carbide, SiC;	7/24/2004	SWS
Laser - Ablate, Remove, Separate.	7/24/2004	SWS
Updated Above Search	1/19/2005	SWS
Search Tools - EAST (attached): USPAT; US PG PUBS; Derwent; EPO; JPO; IBM TDB	7/24/2004	SWS
1-19-05	SWS	